

Absolute Maximum Ratings (Note 1)

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Supply Voltage	+12V to -0.2V
Output Voltage	(+V _S + 0.6V) to _0.6V
Output Current	10 mA
Input Current at any pin (Note 2)	5 mA
Storage Temperature	–65°C to +150°C
Maximum Junction Temperature (T _{JMAX})	+125°C
ESD Susceptibility (Note 3) :	
Human Body Model	2500V
Machine Model	250V

Lead Temperature: SOT Package (Note 4) :	
Vapor Phase (60 seconds)	+215°C
Infrared (15 seconds)	+220°C
Operating Ratings(Note 1)	
Specified Temperature Range:	$\mathbf{T}_{\mathbf{MIN}} \leq \mathbf{T}_{\mathbf{A}} \leq \mathbf{T}_{\mathbf{MAX}}$

LM62B, LM62C Supply Voltage Range (+V_S) Thermal Resistance, $\theta_{JA}(\text{Note 5})$

$$\begin{split} \mathbf{T}_{\mathbf{MIN}} &\leq \mathbf{T}_{\mathbf{A}} \leq \mathbf{T}_{\mathbf{MAX}} \\ 0^{\circ}\mathrm{C} &\leq \mathrm{T}_{\mathrm{A}} \leq +90^{\circ}\mathrm{C} \\ &+2.7\mathrm{V} \text{ to } +10\mathrm{V} \\ &450^{\circ}\mathrm{C}/\mathrm{W} \end{split}$$

Electrical Characteristics

Unless otherwise noted, these specifications apply for +V_S = +3.0 V_{DC}. Boldface limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX} ; all other limits $T_A = T_J = 25^{\circ}C$.

Parameter	Conditions	Typical	LM62B	LM62C	Units
		(Note 6)	Limits	Limits	(Limit)
			(Note 7)	(Note 7)	
Accuracy (Note 8)			±2.0	±3.0	°C (max)
		40	+2.5/-2.0	+4.0/-3.0	°C (max)
Output Voltage at 0°C	. 2	+480			mV
Nonlinearity (Note 9)	a X		±0.8	±1.0	°C (max)
Sensor Gain	32	+16	+16.1	+16.3	mV/°C (max)
(Average Slope)			+15.1	+14.9	mV/°C (min)
Output Impedance	$+3.0V \le +V_S \le +10V$		4.7	4.7	kΩ (max)
	$0^{\circ}C \le T_{A} \le +75^{\circ}C, +V_{S} = +2.7V$		4.4	4.4	kΩ (max)
Line Regulation (Note 10)	$+3.0V \le +V_S \le +10V$		±1.13	±1.13	mV/V (max)
	+2.7V \leq +V _S \leq +3.3V, 0°C \leq T _A \leq +75°C		±9.7	±9.7	mV (max)
Quiescent Current	$+2.7V \le +V_{S} \le +10V$	82	130	130	μA (max)
			165	165	μA (max)
Change of Quiescent Current	$+2.7V \leq +V_S \leq +10V$	±5			μA
Temperature Coefficient of		0.2			µA/°C
Quiescent Current					
Long Term Stability (Note 11)	T _J =T _{MAX} =+100°C, for 1000 hours	±0.2			°C

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions. **Note 2:** When the input voltage (V₁) at any pin exceeds power supplies (V₁ < GND or V₁ > +V_S), the current at that pin should be limited to 5 mA.

Note 3: The human body model is a 100 pF capacitor discharged through a 1.5 kΩ resistor into each pin. The machine model is a 200 pF capacitor discharged directly into each pin.

Note 4: See AN-450 "Surface Mounting Methods and Their Effect on Product Reliability" or the section titled "Surface Mount" found in any post 1986 National Semiconductor Linear Data Book for other methods of soldering surface mount devices.

Note 5: The junction to ambient thermal resistance (θ_{JA}) is specified without a heat sink in still air.

Note 6: Typicals are at $T_J = T_A = 25^{\circ}C$ and represent most likely parametric norm.

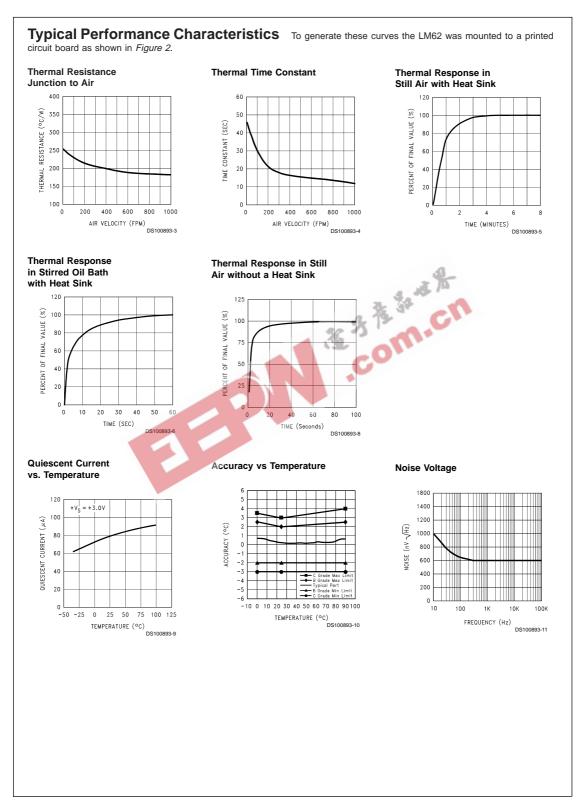
Note 7: Limits are guaranteed to National's AOQL (Average Outgoing Quality Level).

Note 8: Accuracy is defined as the error between the output voltage and +15.6 mV/²C times the device's case temperature plus 480 mV, at specified conditions of voltage, current, and temperature (expressed in ^{*}C).

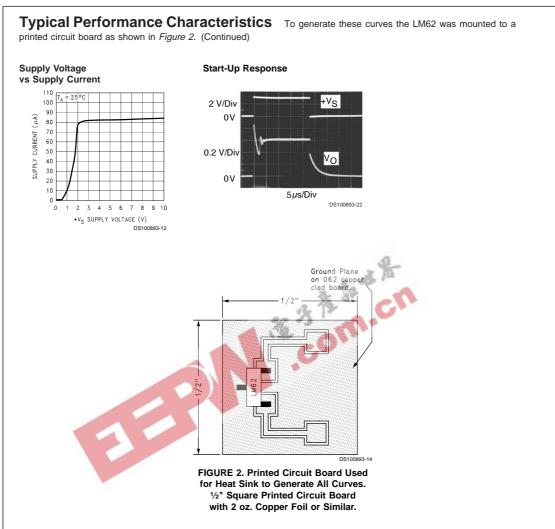
Note 9: Nonlinearity is defined as the deviation of the output-voltage-versus-temperature curve from the best-fit straight line, over the device's rated temperature range.

Note 10: Regulation is measured at constant junction temperature, using pulse testing with a low duty cycle. Changes in output due to heating effects can be computed by multiplying the internal dissipation by the thermal resistance.

Note 11: For best long-term stability, any precision circuit will give best results if the unit is aged at a warm temperature, and/or temperature cycled for at least 46 hours before long-term life test begins. This is especially true when a small (Surface-Mount) part is wave-soldered; allow time for stress relaxation to occur. The majority of the drift will occur in the first 1000 hours at elevated temperatures. The drift after 1000 hours will not continue at the first 1000 hour rate.



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1.0 Mounting

The LM62 can be applied easily in the same way as other integrated-circuit temperature sensors. It can be glued or cemented to a surface. The temperature that the LM62 is sensing will be within about +0.2°C of the surface temperature that LM62's leads are attached to.

This presumes that the ambient air temperature is almost the same as the surface temperature; if the air temperature were much higher or lower than the surface temperature, the actual temperature measured would be at an intermediate temperature between the surface temperature and the air temperature.

To ensure good thermal conductivity the backside of the LM62 die is directly attached to the GND pin. The lands and traces to the LM62 will, of course, be part of the printed circuit board, which is the object whose temperature is being measured. These printed circuit board lands and traces will not cause the LM62's temperature to deviate from the desired temperature.

Alternatively, the LM62 can be mounted inside a sealed-end metal tube, and can then be dipped into a bath or screwed into a threaded hole in a tank. As with any IC, the LM62 and accompanying wiring and circuits must be kept insulated and dry, to avoid leakage and corrosion. This is especially true if the circuit may operate at cold temperatures where condensation can occur. Printed-circuit coatings and varnishes such as Humiseal and epoxy paints or dips are often used to ensure that moisture cannot corrode the LM62 or its connections.

The thermal resistance junction to ambient (θ_{JA}) is the parameter used to calculate the rise of a device junction temperature due to its power dissipation. For the LM62 the equation used to calculate the rise in the die temperature is as follows:

$$T_{J} = T_{A} + \theta_{JA} \left[(+V_{S} I_{Q}) + (+V_{S} - V_{O}) I_{L} \right]$$

where ${\sf I}_{\sf Q}$ is the quiescent current and ${\sf I}_{\sf L}$ is the load current on the output. Since the LM62's junction temperature is the actual temperature being measured care should be taken to minimize the load current that the LM62 is required to drive.

1.0 Mounting (Continued)

The table shown in Figure 3 summarizes the rise in die temperature of the LM62 without any loading, and the thermal resistance for different conditions

	SOT-23 no heat sink		SOT-23 small heat fin		
	(Note 13)		(Note 12)		
	θ _{JA}	$T_J - T_A$	θ_{JA}	$T_J - T_A$	
	(°C/W)	(°C)	(°C/W)	(°C)	
Still air	450	0.17	260	0.1	
Moving			180	0.07	
air					

Note 12: Heat sink used is $\frac{1}{2}$ " square printed circuit board with 2 oz. foil with part attached as shown in Figure 2.

Note 13: Part soldered to 30 gauge wire.

FIGURE 3. Temperature Rise of LM62 Due to Self-Heating and Thermal Resistance (θ_{JA})

2.0 Capacitive Loads

Q 1 Q2 10E

+Vs

GND

The LM62 handles capacitive loading well. Without any spe-cial precautions, the LM62 can drive any capacitive load as shown in Figure 4. Over the specified temperature range the LM62 has a maximum output impedance of 4.7 kΩ. In an extremely noisy environment it may be necessary to add some filtering to minimize noise pickup. It is recommended that

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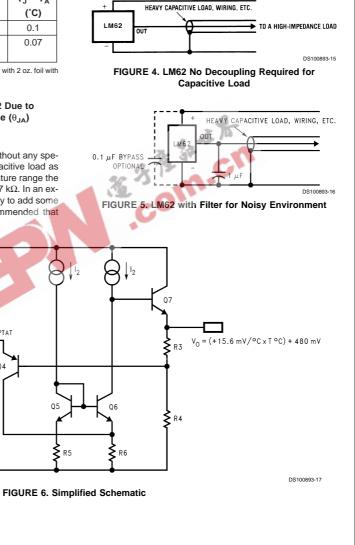
Q4

R 1

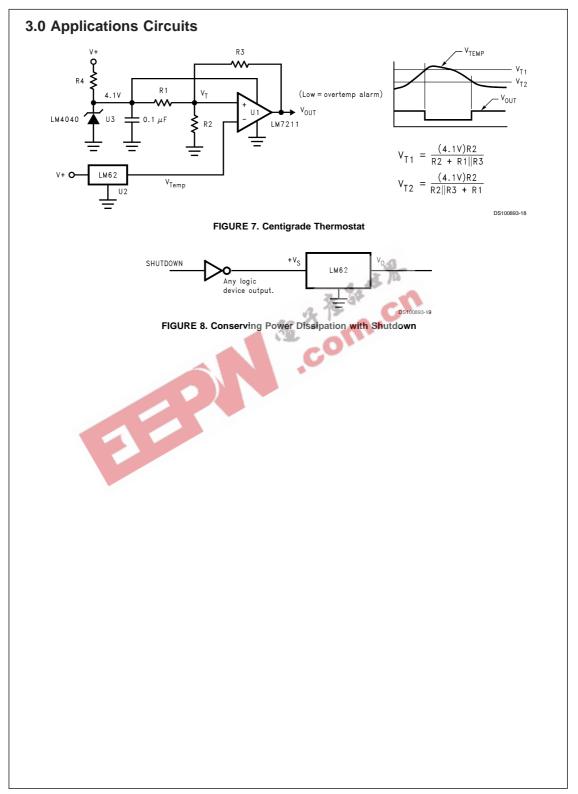
Ş R2

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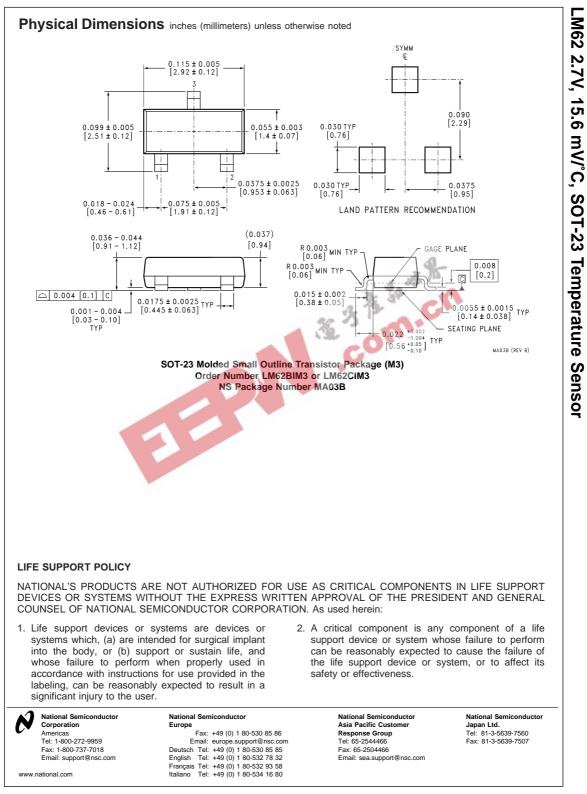
0.1 μ F be added from +V_S to GND to bypass the power supply voltage, as shown in Figure 5. In a noisy environment it may be necessary to add a capacitor from the output to ground. A 1 μF output capacitor with the 4.7 k Ω maximum output impedance will form a 34 Hz lowpass filter. Since the thermal time constant of the LM62 is much slower than the 30 ms time constant formed by the RC, the overall response time of the LM62 will not be significantly affected. For much larger capacitors this additional time lag will increase the overall response time of the LM62.



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